

Important notice

Dear Customer,

On 7 February 2017 the former NXP Standard Product business became a new company with the tradename **Nexperia**. Nexperia is an industry leading supplier of Discrete, Logic and PowerMOS semiconductors with its focus on the automotive, industrial, computing, consumer and wearable application markets

In data sheets and application notes which still contain NXP or Philips Semiconductors references, use the references to Nexperia, as shown below.

Instead of http://www.nxp.com, http://www.nxp.com, http://www.nexperia.com/, use http://www.nexperia.com/

Instead of sales.addresses@www.nxp.com or sales.addresses@www.semiconductors.philips.com, use salesaddresses@nexperia.com (email)

Replace the copyright notice at the bottom of each page or elsewhere in the document, depending on the version, as shown below:

- © NXP N.V. (year). All rights reserved or © Koninklijke Philips Electronics N.V. (year). All rights reserved

Should be replaced with:

- © Nexperia B.V. (year). All rights reserved.

If you have any questions related to the data sheet, please contact our nearest sales office via e-mail or telephone (details via **salesaddresses@nexperia.com**). Thank you for your cooperation and understanding,

Kind regards,

Team Nexperia

BUK755R2-40B

N-channel TrenchMOS standard level FET

Rev. 02 — 16 January 2009

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- Q101 compliant
- Suitable for standard level gate drive sources
- Suitable for thermally demanding environments due to 175 °C rating

1.3 Applications

- 12 V loads
- Automotive systems

- General purpose power switching
- Motors, lamps and solenoids

1.4 Quick reference data

Table 1. Quick reference

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|----------------------|--|---|-----|-----|-----|-----|------|
| V_{DS} | drain-source voltage | $T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$ | | - | - | 40 | V |
| I_D | drain current | V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 1</u> ; see <u>Figure 3</u> ; | [1] | - | - | 75 | Α |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see <u>Figure 2</u> | | - | - | 203 | W |
| Avalanc | he ruggedness | | | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | I_D = 75 A; $V_{sup} \le 40 \text{ V}$; R_{GS} = 50 Ω ; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; unclamped | | - | - | 494 | mJ |
| Dynamic | characteristics | | | | | | |
| Q_{GD} | gate-drain charge | $V_{GS} = 10 \text{ V; } I_D = 25 \text{ A;}$ $V_{DS} = 32 \text{ V; } T_j = 25 \text{ °C; see}$ <u>Figure 14</u> | | - | 16 | - | nC |
| Static ch | aracteristics | | | | | | |
| R _{DSon} | drain-source on-state resistance | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 11}}{\text{Figure 12}};$ see $\frac{\text{Figure 12}}{\text{Figure 12}}$ | | - | 4.4 | 5.2 | mΩ |

^[1] Continuous current is limited by package.



2. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-----------------------------------|------------------------|----------------------------------|
| 1 | G | gate | | _ |
| 2 | D | drain | mb | D |
| 3 | S | source | | $G \longrightarrow \overline{A}$ |
| mb | D | mounting base; connected to drain | 1 2 3 SOT78A | mbb076 S |
| | | | (3-leadTO-220AB;SC-46) | |

3. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|--------------|---------------------------|--|---------|
| | Name | Description | Version |
| BUK755R2-40B | 3-lead TO-220AB; SC-46 | plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB | SOT78A |

3 of 13

Limiting values

Table 4. Limiting values

Product data sheet

In accordance with the Absolute Maximum Rating System (IEC 60134).

| O | B | A control of the cont | | | | 11.11 |
|----------------------|--|--|-----|-----|-----|-------|
| Symbol | Parameter | Conditions | | Min | Max | Unit |
| V_{DS} | drain-source voltage | $T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$ | | - | 40 | V |
| V_{DGR} | drain-gate voltage | $R_{GS} = 20 \text{ k}\Omega$ | | - | 40 | V |
| V_{GS} | gate-source voltage | | | -20 | 20 | V |
| I_D | drain current | $T_{mb} = 25 ^{\circ}\text{C}$; $V_{GS} = 10 \text{V}$; see <u>Figure 1</u> ; see <u>Figure 3</u> ; | [1] | - | 143 | Α |
| | | T _{mb} = 25 °C; V _{GS} = 10 V; see <u>Figure 1</u> ; see <u>Figure 3</u> ; | [2] | - | 75 | Α |
| | | $T_{mb} = 100 ^{\circ}\text{C}; V_{GS} = 10 \text{V}; \text{see } \underline{\text{Figure 1}};$ | [2] | - | 75 | Α |
| I_{DM} | peak drain current | $T_{mb} = 25 \text{ °C}; t_p \le 10 \text{ µs}; \text{ pulsed}; \text{ see } \frac{\text{Figure 3}}{}$ | | - | 573 | Α |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see <u>Figure 2</u> | | - | 203 | W |
| T _{stg} | storage temperature | | | -55 | 175 | °C |
| Tj | junction temperature | | | -55 | 175 | °C |
| Source-dra | ain diode | | | | | |
| Is | source current | $T_{mb} = 25 ^{\circ}C;$ | [1] | - | 143 | Α |
| | | T _{mb} = 25 °C; | [2] | - | 75 | Α |
| I _{SM} | peak source current | $t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$ | | - | 573 | Α |
| Avalanche | ruggedness | | | | | |
| E _{DS(AL)S} | non-repetitive drain-source avalanche energy | I_D = 75 A; V_{sup} ≤ 40 V; R_{GS} = 50 Ω ; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; unclamped | | - | 494 | mJ |

^[1] Current is limited by power dissipation chip rating.

Continuous current is limited by package.

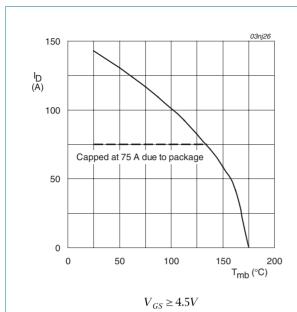
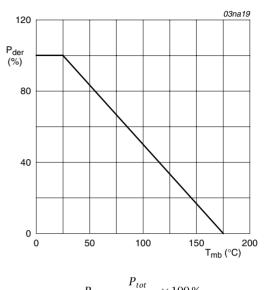
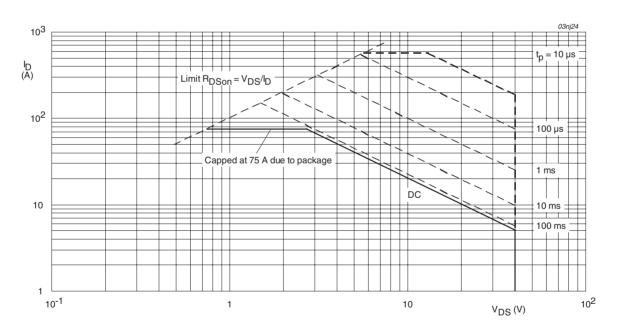


Fig 1. Continuous drain current as a function of mounting base temperature



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized total power dissipation as a function of mounting base temperature



 $T_{mb} = 25$ °C; I_{DM} is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5 of 13

5. Thermal characteristics

Table 5. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------|---|-----------------------|-----|-----|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | see Figure 4 | - | - | 0.74 | K/W |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | vertical in still air | - | 60 | - | K/W |

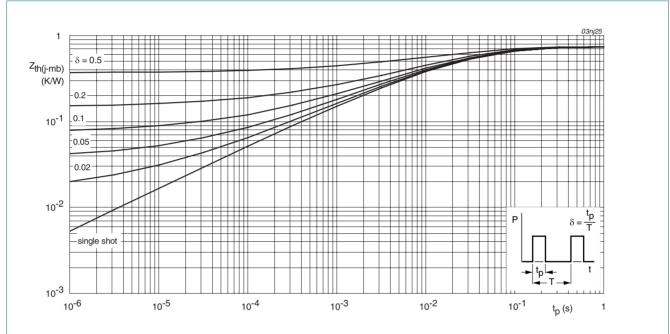


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--|----------------------------------|---|-----|------|------|------|
| • | racteristics | | | | | |
| V _{(BR)DSS} drain-source | | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | 40 | - | - | V |
| | breakdown voltage | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$ | 36 | - | - | V |
| V _{GS(th)} gate-source threshol voltage | | I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 25 °C; see Figure 10 | 2 | 3 | 4 | V |
| | | $I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = 175$ °C; see Figure 10 | 1 | - | - | V |
| | | $I_D = 1$ mA; $V_{DS} = V_{GS}$; $T_j = -55$ °C; see Figure 10 | - | - | 4.4 | V |
| I _{DSS} | drain leakage current | $V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | - | 0.02 | 1 | μΑ |
| | | $V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$ | - | - | 500 | μΑ |
| I _{GSS} | gate leakage current | V _{DS} = 0 V; V _{GS} = 20 V; T _j = 25 °C | - | 2 | 100 | nA |
| | | V _{DS} = 0 V; V _{GS} = -20 V; T _j = 25 °C | - | 2 | 100 | nA |
| R _{DSon} | drain-source on-state resistance | V_{GS} = 10 V; I_D = 25 A; T_j = 25 °C; see Figure 11; see Figure 12 | - | 4.4 | 5.2 | mΩ |
| | | V_{GS} = 10 V; I_D = 25 A; T_j = 175 °C; see Figure 11; see Figure 12 | - | - | 9.9 | mΩ |
| Dynamic | characteristics | | | | | |
| Q _{G(tot)} | total gate charge | $I_D = 25 \text{ A}; V_{DS} = 32 \text{ V}; V_{GS} = 10 \text{ V};$ | - | 52 | - | nC |
| Q_{GS} | gate-source charge | T _j = 25 °C; see <u>Figure 14</u> | - | 12 | - | nC |
| Q_{GD} | gate-drain charge | | - | 16 | - | nC |
| C _{iss} | input capacitance | $V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$ | - | 2842 | 3789 | рF |
| C _{oss} | output capacitance | T _j = 25 °C; see <u>Figure 15</u> | - | 711 | 853 | рF |
| C_{rss} | reverse transfer capacitance | | - | 296 | 406 | pF |
| t _{d(on)} | turn-on delay time | V_{DS} = 30 V; R_L = 1.2 Ω ; V_{GS} = 10 V; | - | 15 | - | ns |
| t _r | rise time | $R_{G(ext)} = 10 \Omega; T_j = 25 °C$ | - | 51 | - | ns |
| t _{d(off)} | turn-off delay time | | - | 81 | - | ns |
| t _f | fall time | | - | 56 | - | ns |
| L _D | internal drain inductance | from drain lead 6 mm from package to centre of die; $T_j = 25 ^{\circ}\text{C}$ | - | 4.5 | - | nΗ |
| | | from contact screw on mounting base to centre of die; $T_j = 25$ °C | - | 3.5 | - | nΗ |
| L _S | internal source inductance | from source lead to source bond pad; $T_j = 25 ^{\circ}\text{C}$ | - | 7.5 | - | nΗ |
| Source-d | rain diode | | | | | |
| V_{SD} | source-drain voltage | $I_S = 25 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 \text{ °C}$; see Figure 13 | - | 0.85 | 1.2 | V |
| t _{rr} | reverse recovery time | $I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = -10 \text{ V};$ | - | 54 | - | ns |
| Qr | recovered charge | $V_{DS} = 20 \text{ V}; T_j = 25 \text{ °C}$ | - | 38 | - | nC |

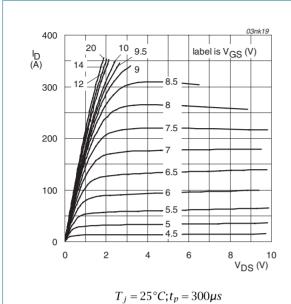


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

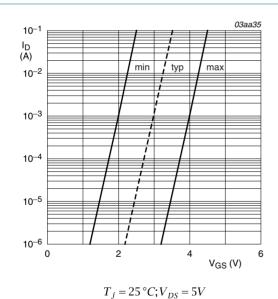
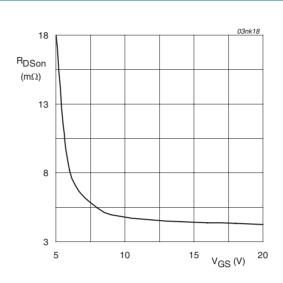
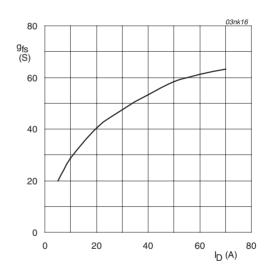


Fig 7. Sub-threshold drain current as a function of gate-source voltage



 $T_j = 25^{\circ}C; I_D = 25A$

Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values



 $T_i = 25^{\circ}C; V_{DS} = 25V$

Fig 8. Forward transconductance as a function of drain current; typical values

03aa32

N-channel TrenchMOS standard level FET

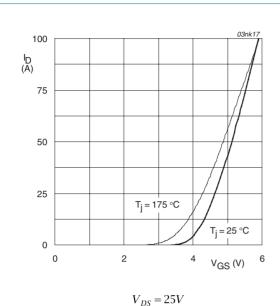
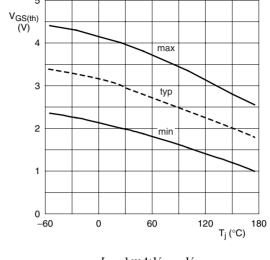


Fig 9. Transfer characteristics: drain current as a function of gate-source voltage; typical values



 $I_D = 1 \, mA; V_{DS} = V_{GS}$

Fig 10. Gate-source threshold voltage as a function of junction temperature

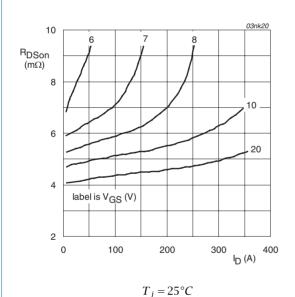


Fig 11. Drain-source on-state resistance as a function of drain current; typical values

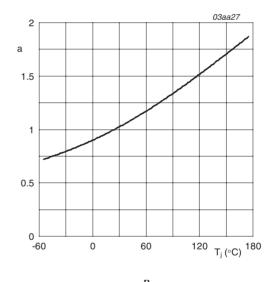


Fig 12. Normalized drain-source on-state resistance factor as a function of junction temperature

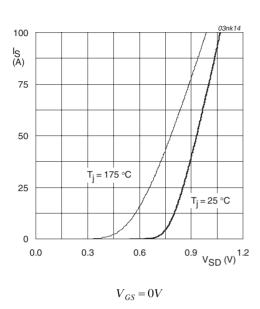
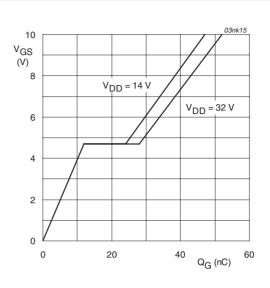
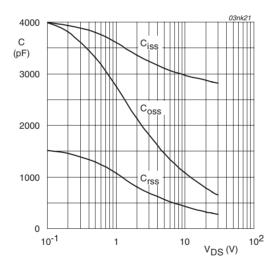


Fig 13. Source current as a function of source-drain voltage; typical values



 $T_i = 25^{\circ}C; I_D = 25A$

Fig 14. Gate-source voltage as a function of gate charge; typical values



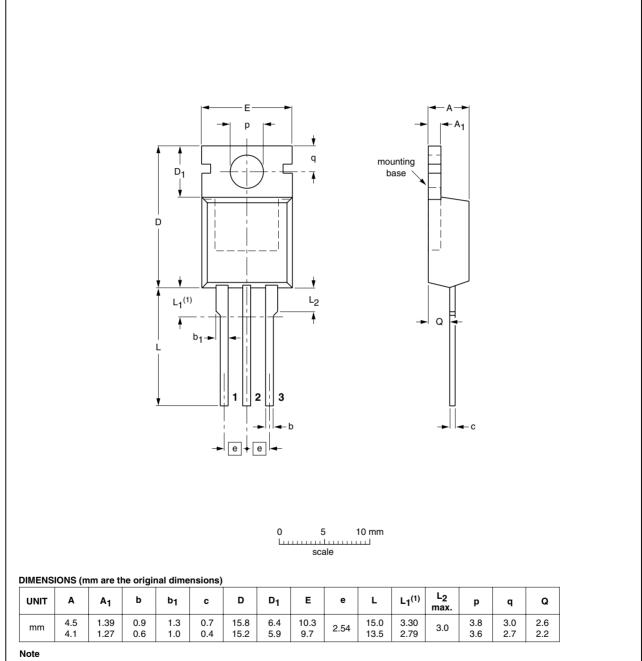
 $V_{GS} = 0V; f = 1MHz$

Fig 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

7. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78A



1. Terminals in this zone are not tinned.

| OUTLINE | | REFER | ENCES | EUROPEAN | ISSUE DATE |
|---------|-----|-----------------|-------|------------|---------------------------------|
| VERSION | IEC | JEDEC | JEITA | PROJECTION | 1330E DATE |
| SOT78A | | 3-lead TO-220AB | SC-46 | | 03-01-22 05-03-14 |

Fig 16. Package outline SOT78A (3-lead TO-220AB; SC-46)



8. Revision history

Table 7. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes | | |
|--------------------|---|---|----------------------|--------------------|--|--|
| BUK755R2-40B_2 | 20090116 | Product data sheet | - | BUK75_765R2_40B-01 | | |
| Modifications: | The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. | | | | | |
| | Legal texts | have been adapted to the | e new company name w | here appropriate. | | |
| | Type numb | number BUK755R2-40B separated from data sheet BUK75_765R2_40B-01. | | | | |
| | Package or | utline updated. | | | | |
| BUK75_765R2_40B-01 | 20030514 | Product data sheet | - | - | | |

9. Legal information

9.1 Data sheet status

| Document status [1][2] | Product status[3] | Definition |
|--------------------------------|-------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

9.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

9.3 Disclaimers

General — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in medical, military, aircraft, space or life support equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors accepts no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) may cause permanent damage to the device. Limiting values are stress ratings only and operation of the device at these or any other conditions above those given in the Characteristics sections of this document is not implied. Exposure to limiting values for extended periods may affect device reliability.

Terms and conditions of sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nxp.com/profile/terms, including those pertaining to warranty, intellectual property rights infringement and limitation of liability, unless explicitly otherwise agreed to in writing by NXP Semiconductors. In case of any inconsistency or conflict between information in this document and such terms and conditions, the latter will prevail.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

9.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

TrenchMOS — is a trademark of NXP B.V.

10. Contact information

For more information, please visit: http://www.nxp.com

For sales office addresses, please send an email to: salesaddresses@nxp.com

BUK755R2-40B

N-channel TrenchMOS standard level FET

11. Contents

| 1 | Product profile | 1 |
|-----|-------------------------|----|
| 1.1 | General description | 1 |
| 1.2 | Features and benefits | 1 |
| 1.3 | Applications | 1 |
| 1.4 | Quick reference data | 1 |
| 2 | Pinning information | 2 |
| 3 | Ordering information | 2 |
| 4 | Limiting values | 3 |
| 5 | Thermal characteristics | 5 |
| 6 | Characteristics | 6 |
| 7 | Package outline | 10 |
| 8 | Revision history | 11 |
| 9 | Legal information | 12 |
| 9.1 | Data sheet status | 12 |
| 9.2 | Definitions | 12 |
| 9.3 | Disclaimers | 12 |
| 9.4 | Trademarks | 12 |
| 10 | Contact information | 19 |

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

